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Nature of Quality Factor Degradation in SRF Cavities due to Quench

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Introduction

- Q_0 degradation due to quench in bulk niobium cavities attributed to trapped magnetic flux¹.
- Where does this flux come from?
 - Thermocurrents at the quench spot¹
 - Trapped RF field
 - Ambient field²
- We have proved that the Q_0 quench-related degradation mechanism is **due only** to the **trapping of ambient magnetic field**.

¹ J. Knobloch, H. Padamsee, *Proceedings of the 8th Workshop on RF Superconductivity*, Abano Terme, Italy (1997)

² I.M. Terekhine *et al.*, *Proceedings of 13th International Conference on RF Superconductivity*, Paris, France (2013)

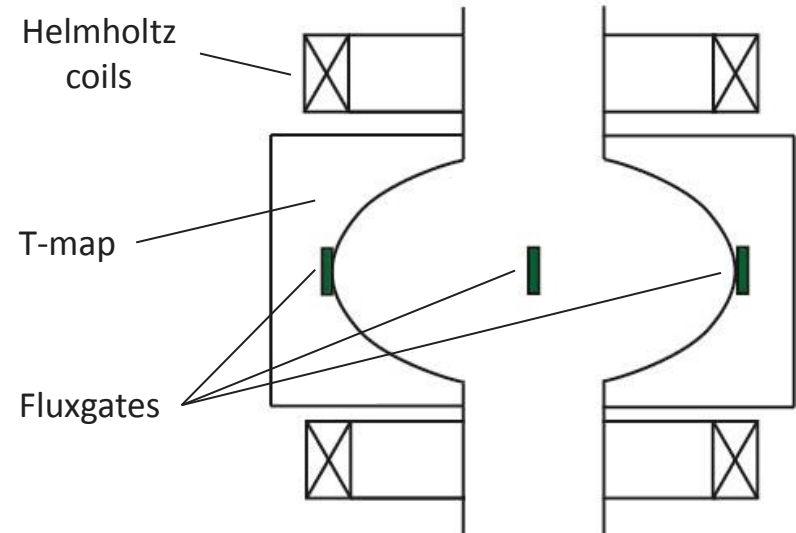
Experimental Set-up & Procedure

Set-up:

- Helmholtz coils
- 4 Fluxgates magnetometers
- T-map system

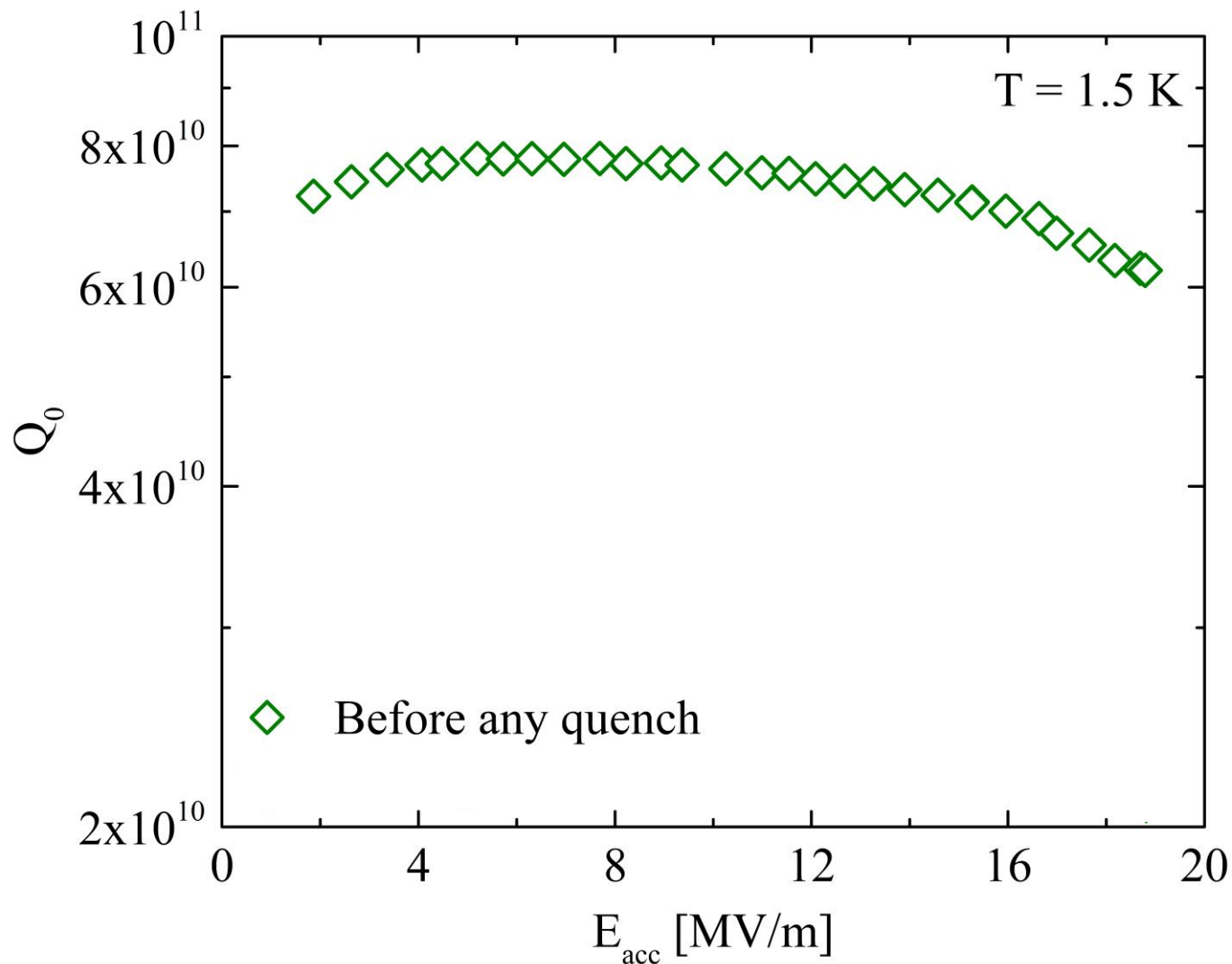
Procedure:

1. Q_0 vs E_{acc} before any quench
2. Cavity quench with RF field
 - i. Different values of external magnetic field
 - ii. Field compensation till $H < 1$ mOe
3. Q_0 and T-map measured after the quench

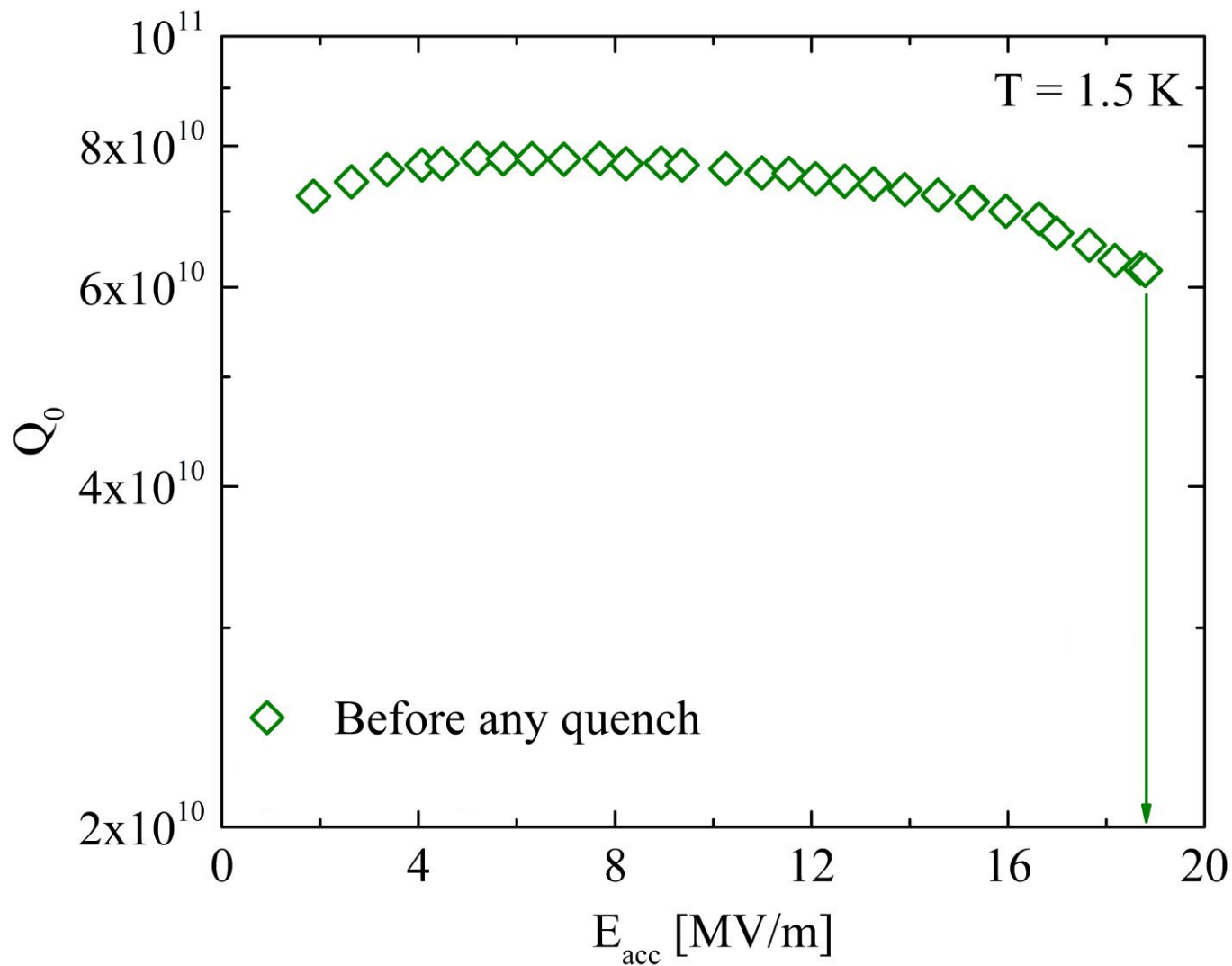


Q_0 recovery and origin of trapped magnetic flux

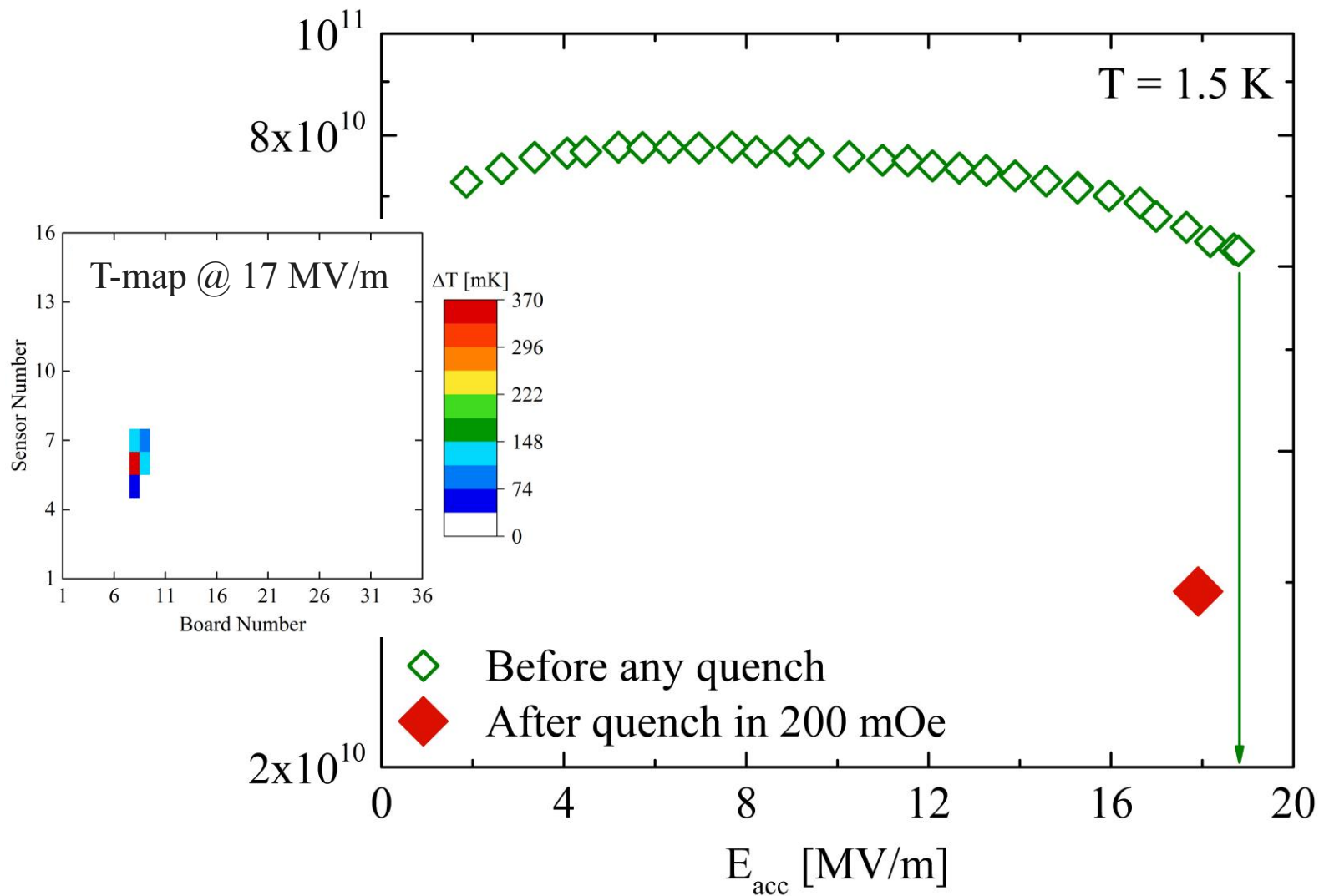
Q_0 vs E_{acc} before any quench



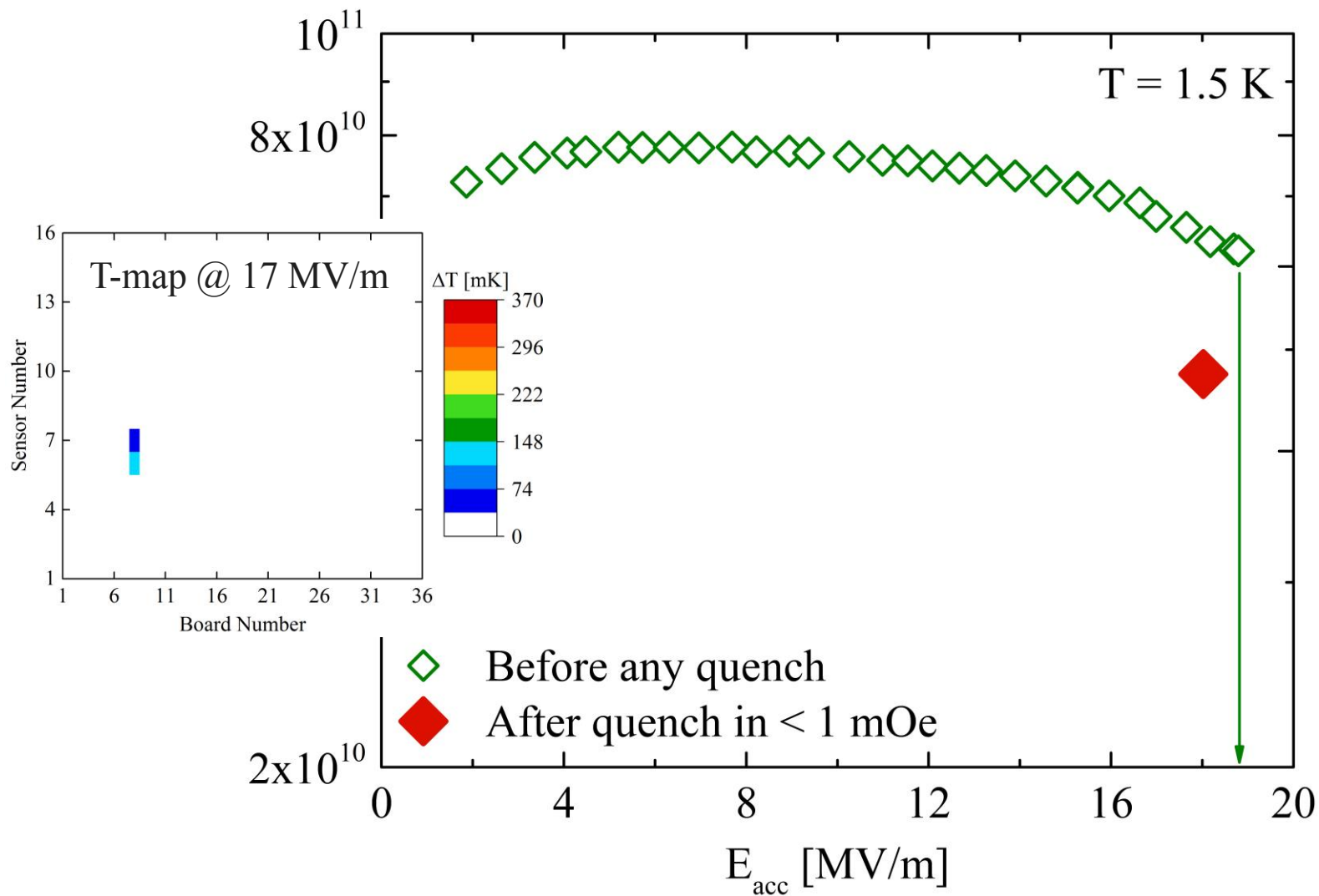
Cavity quench with RF field



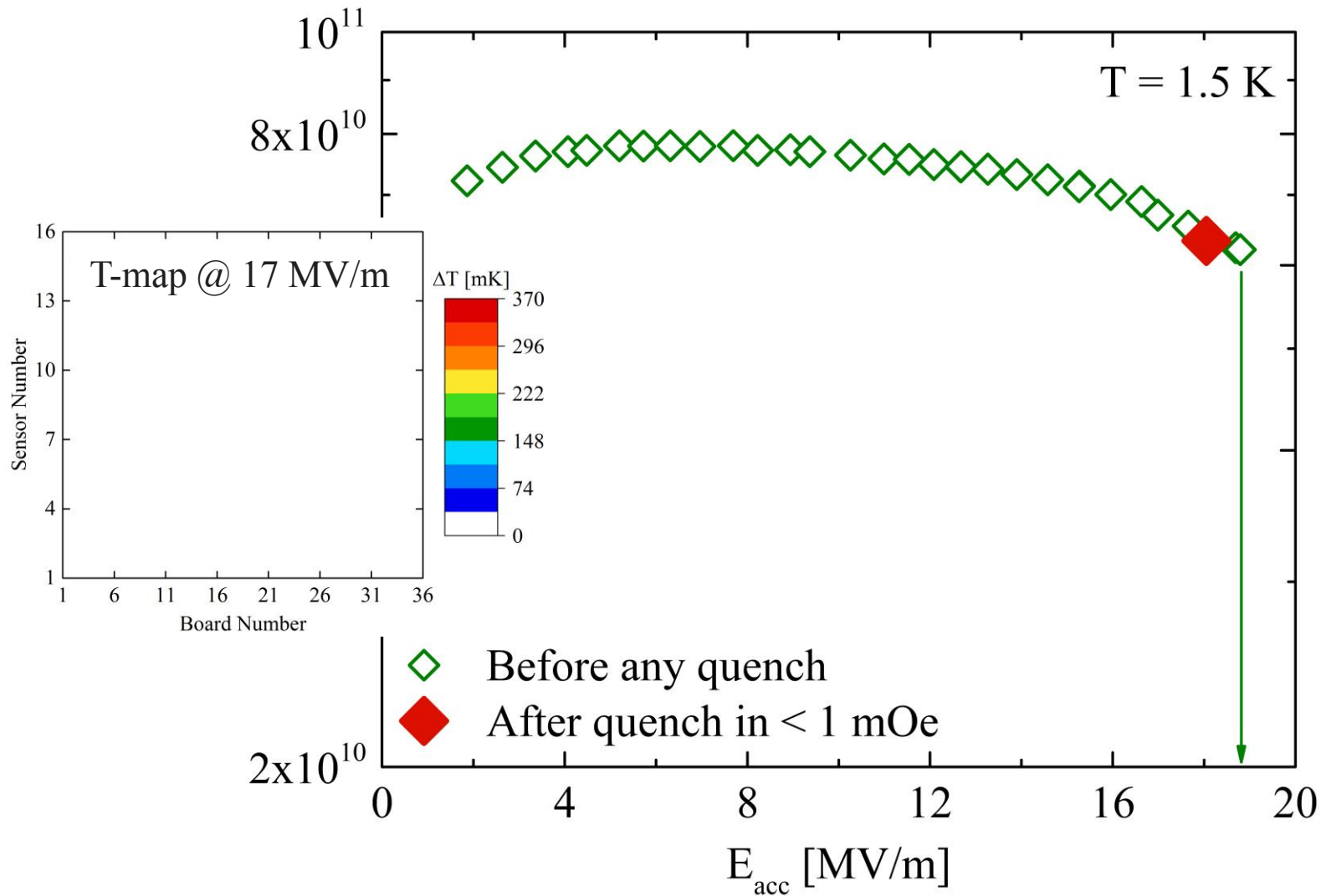
Quench in 200 mOe



Quench in < 1 mOe



Quench in < 1 mOe

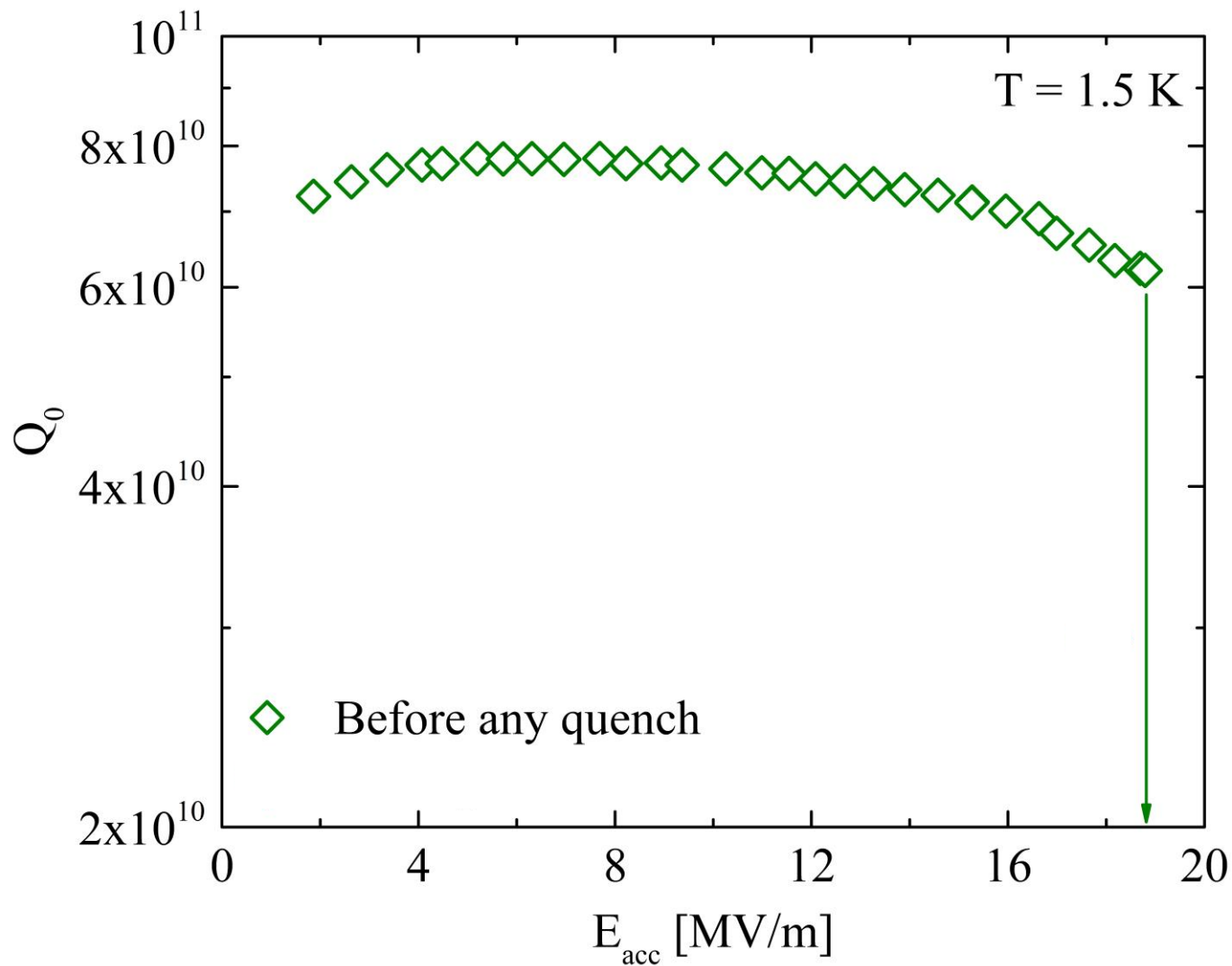


Complete Q_0 Recovery!

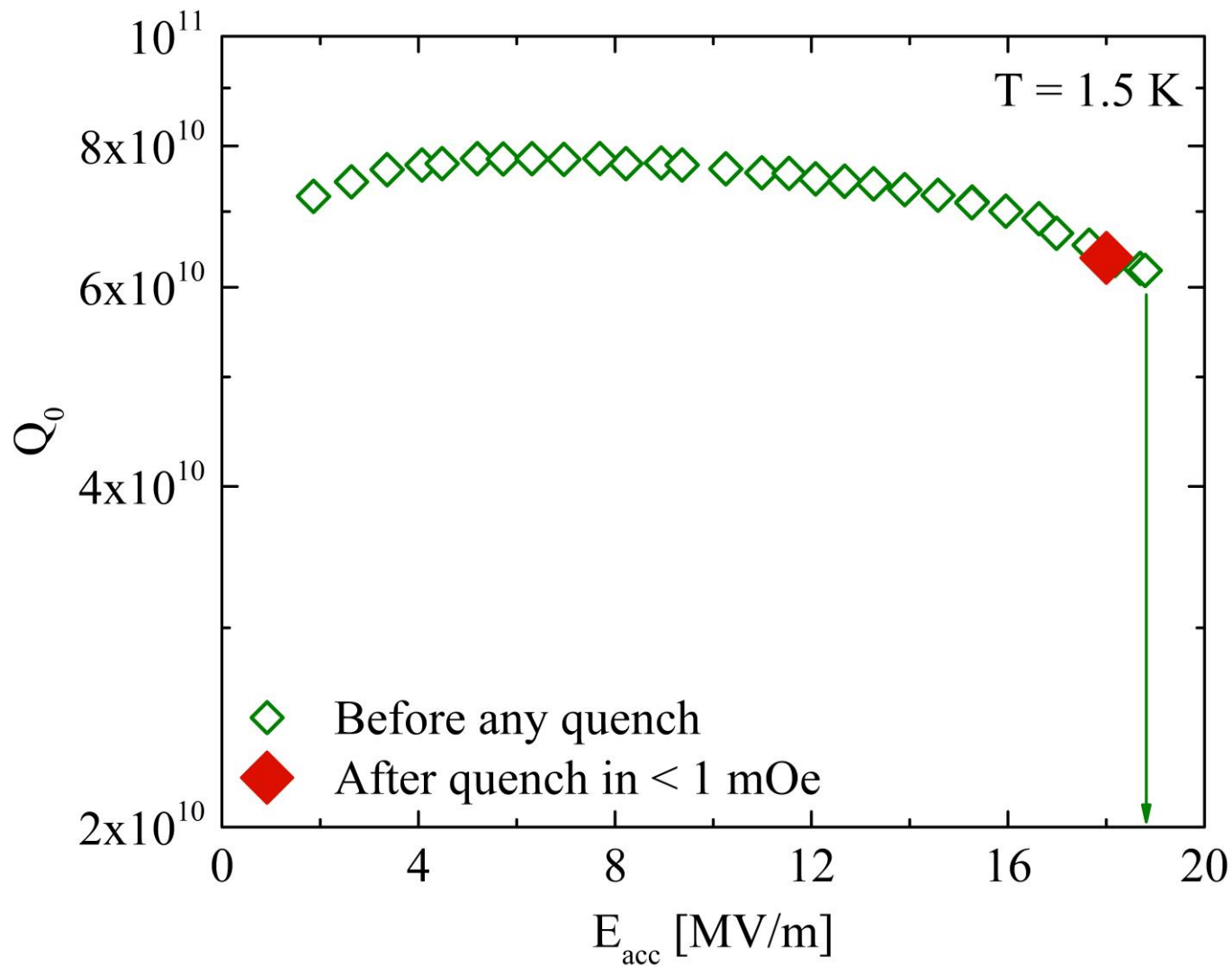
Without warming above T_c

→ First hint on the extrinsic origin of flux trapping

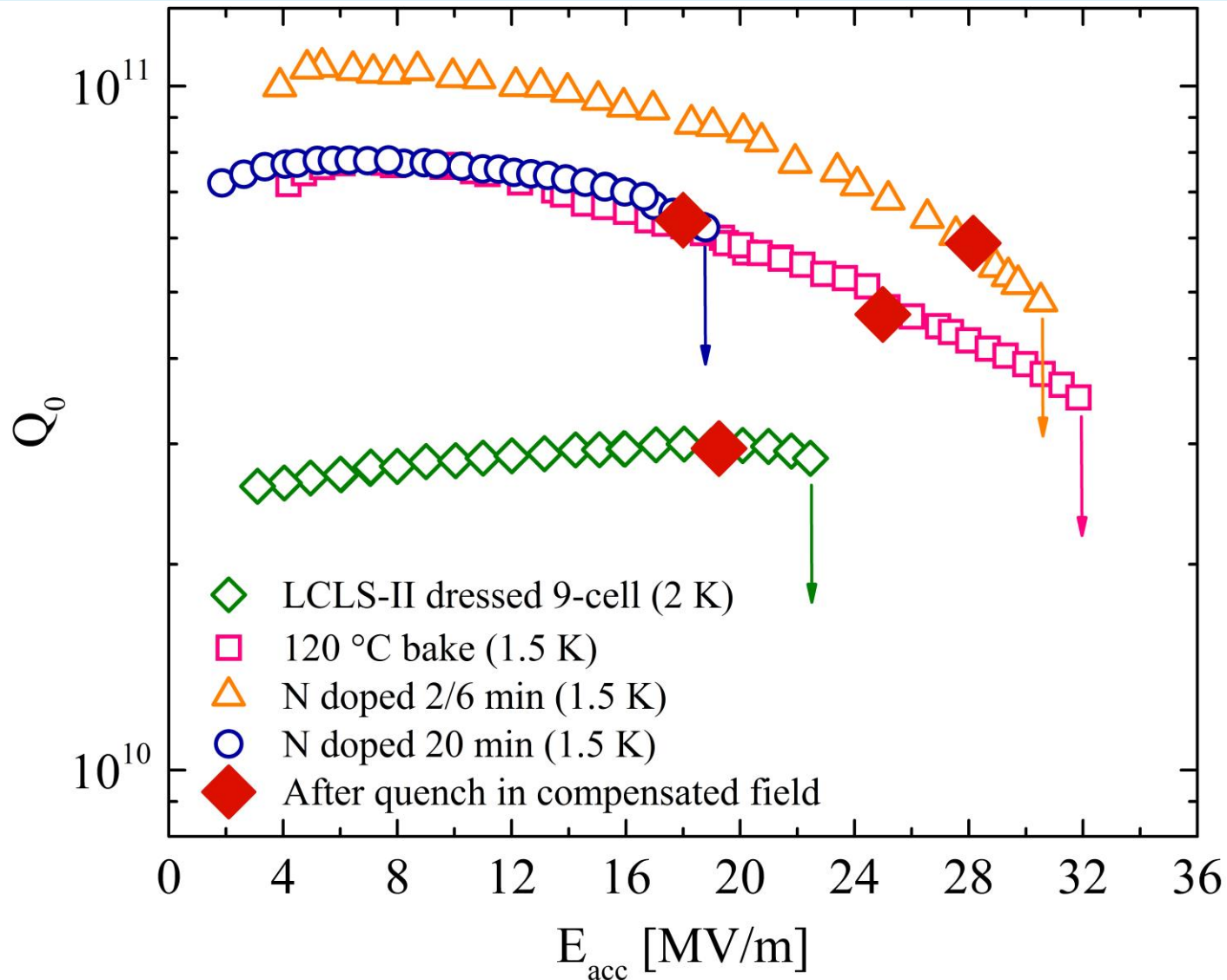
Q_0 vs E_{acc} before any quench



Quench in < 1 mOe



Quench in < 1 mOe for different treatments



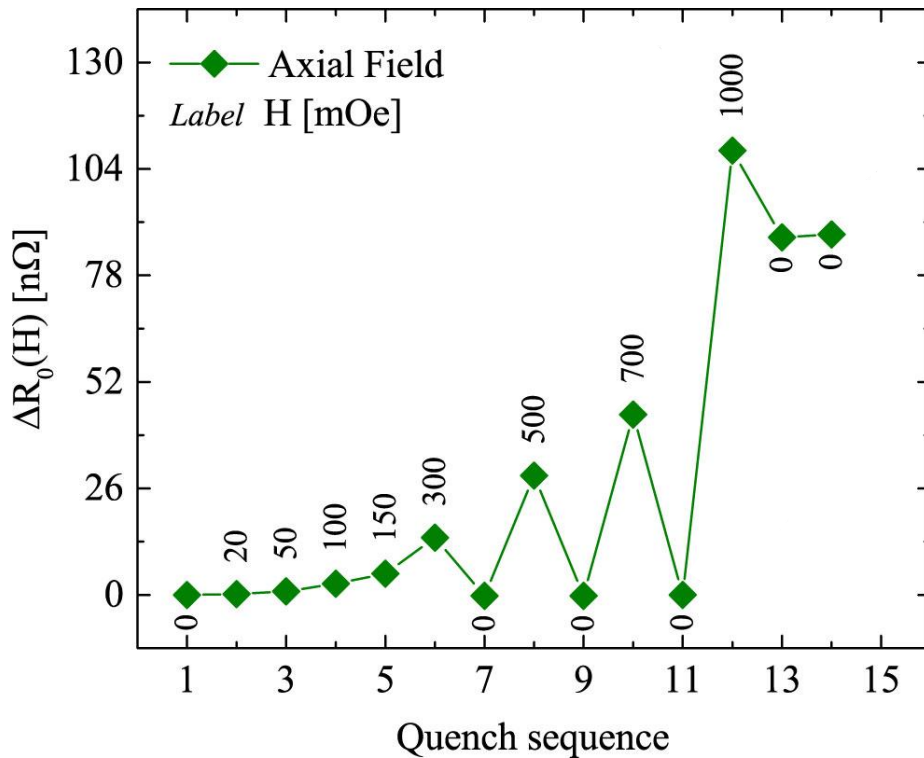
No Q_0 Degradation!

Flux trapping is an extrinsic phenomenon
only!

Is Q_0 always totally recoverable?

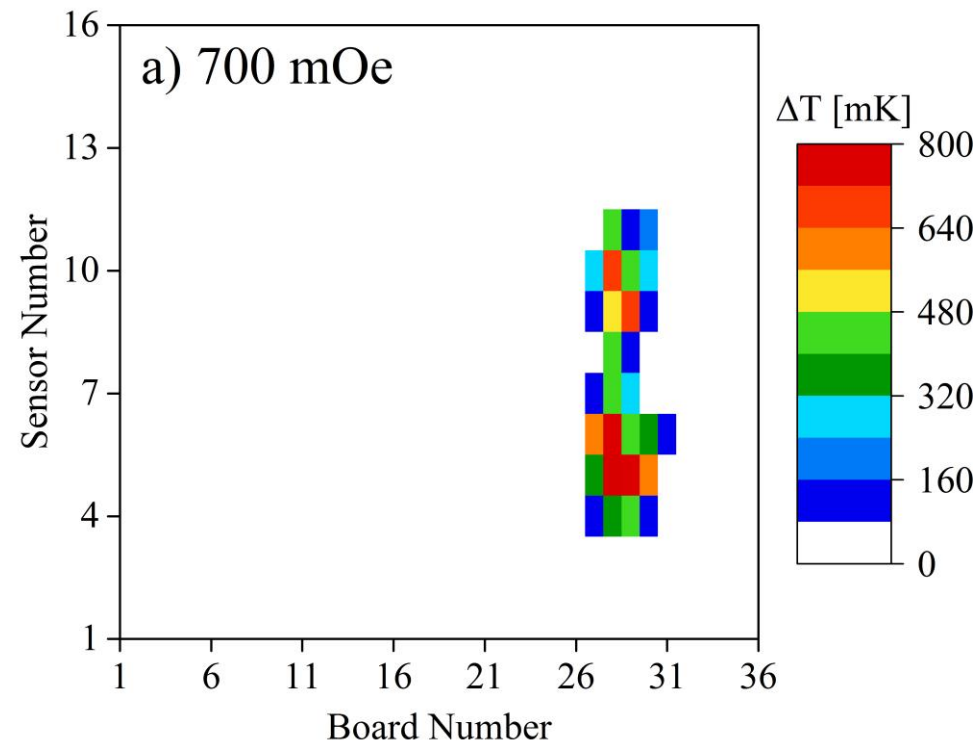
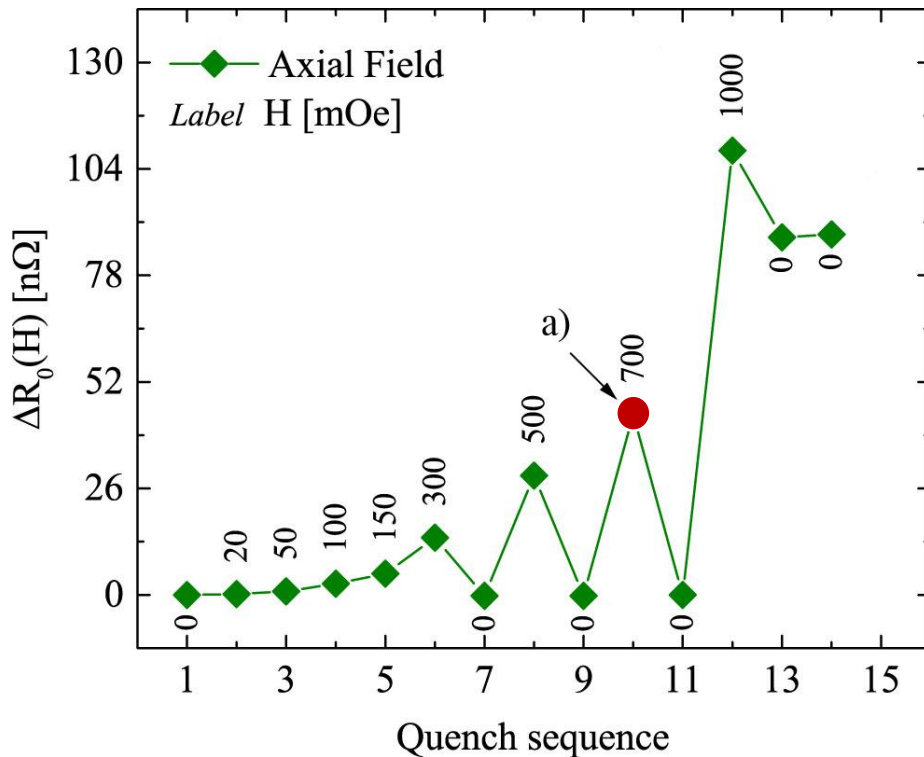
Not complete recovery

Not always the Q-factor can be totally recovered



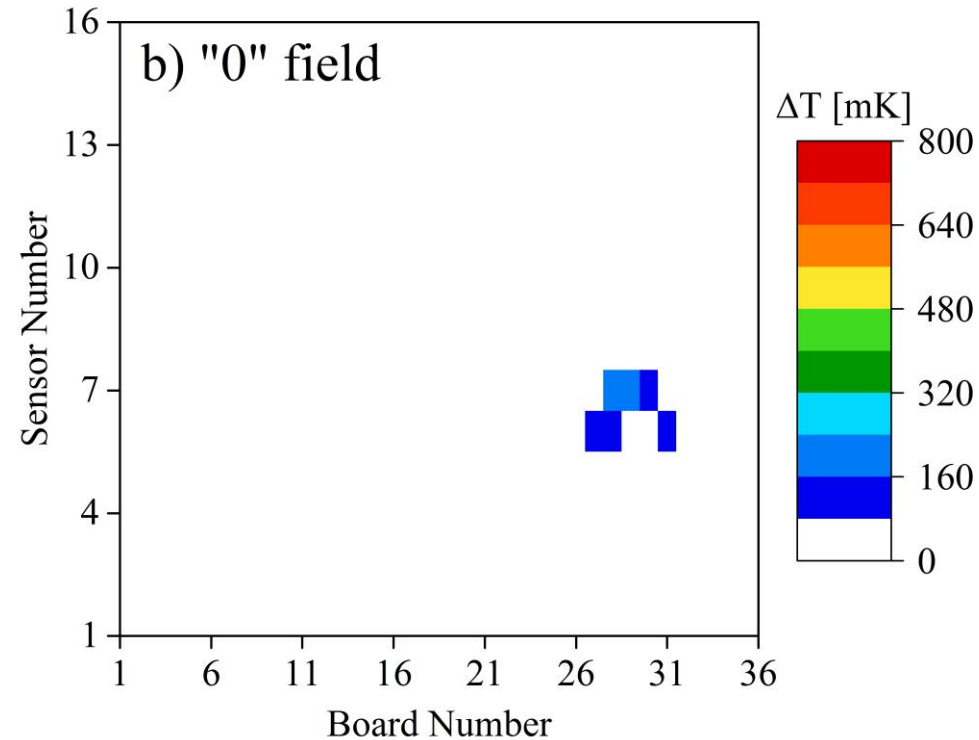
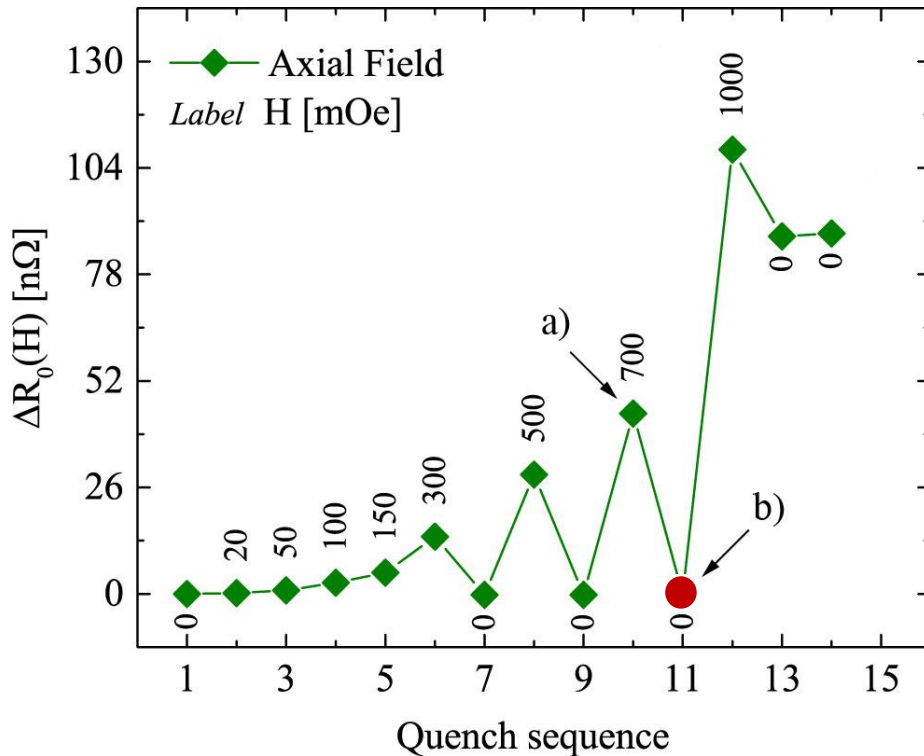
Not complete recovery

Not always the Q-factor can be **totally** recovered



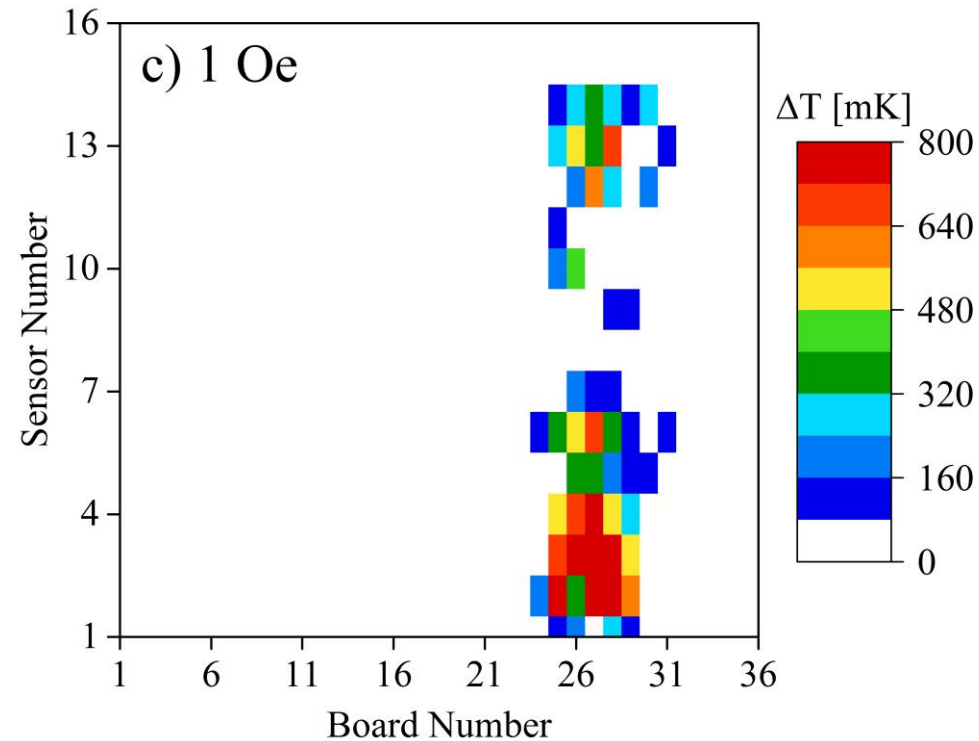
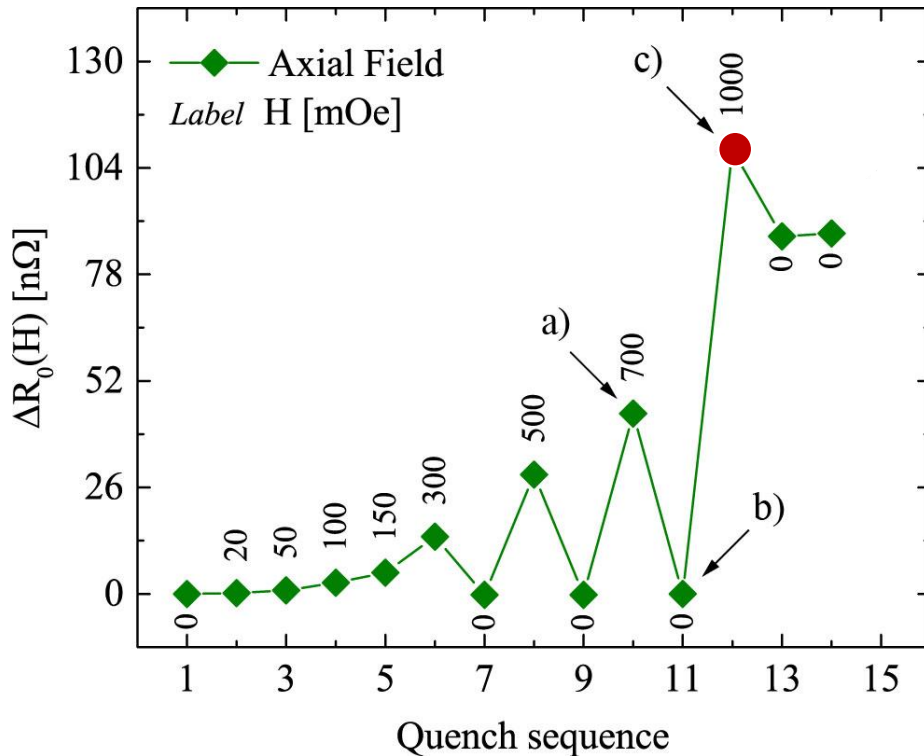
Not complete recovery

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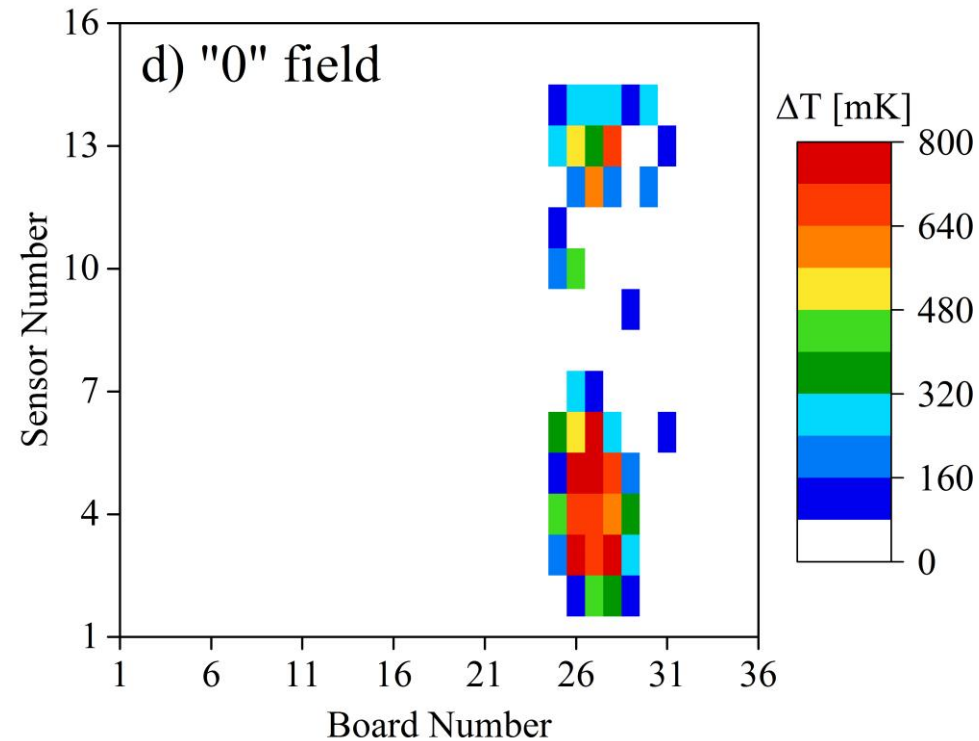
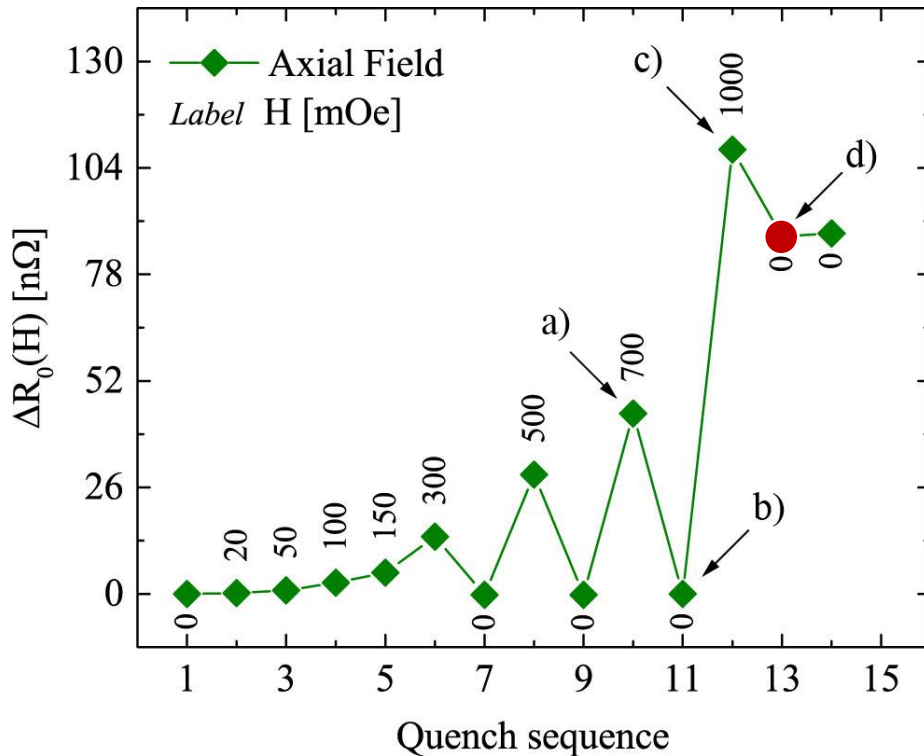
Not complete recovery

Not always the Q-factor can be **totally** recovered



Not complete recovery

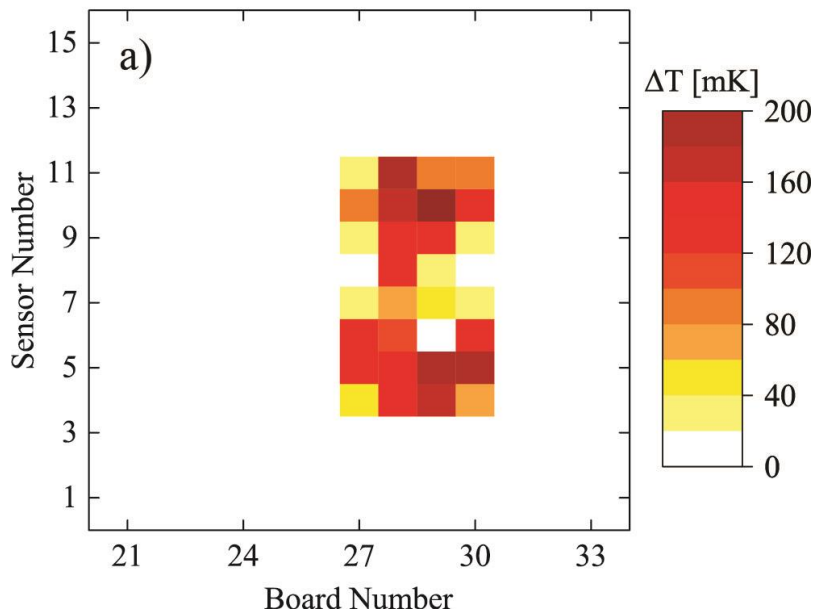
Not always the Q-factor can be **totally** recovered



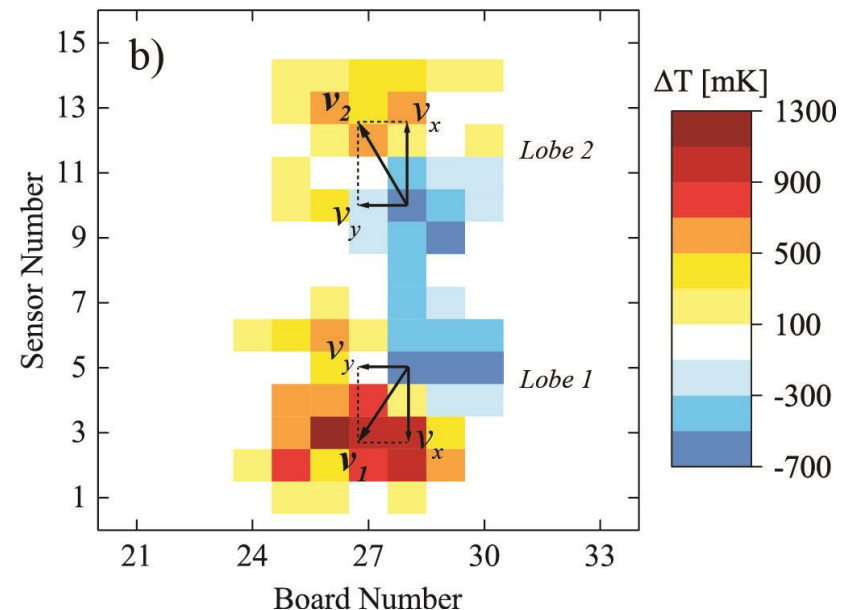
The flux migrates driven by its own thermal gradient

$$-S\nabla T - \eta \bar{v} - f n_s e (\bar{v} \times \phi_0 \hat{n}) - \bar{f}_p = 0$$

700 mOe – 500 mOe



1 Oe – 700 mOe



How is the flux trapped?

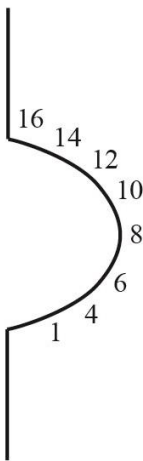
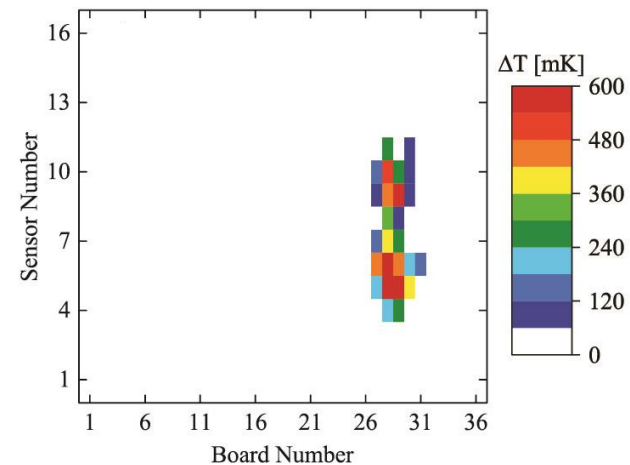
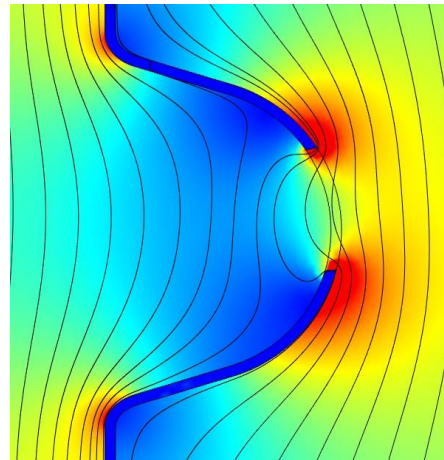
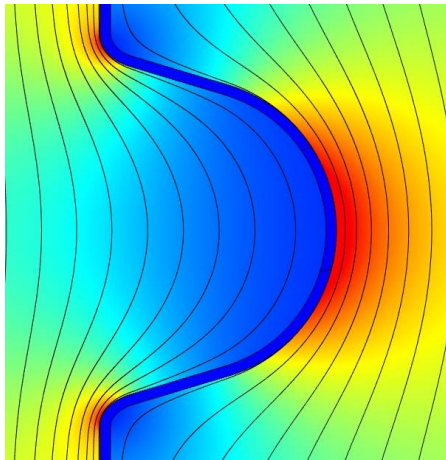
Magnetic flux trapping dynamics

How the magnetic flux is trapped?

It creates a semi-loop at the quench spot

Why the magnetic flux is not expelled?

Hypothesis: field redistribution time constant $>$ than cooling time constant



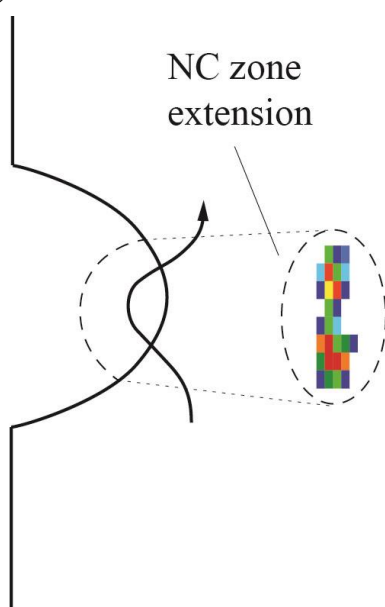
How does the recovery work?

How does the Q_0 recovery work?

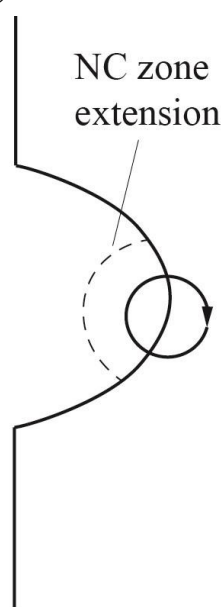
Magnetic field exists only if currents are present

$$\oint \vec{B} \cdot d\vec{l} = \mu_0 I$$

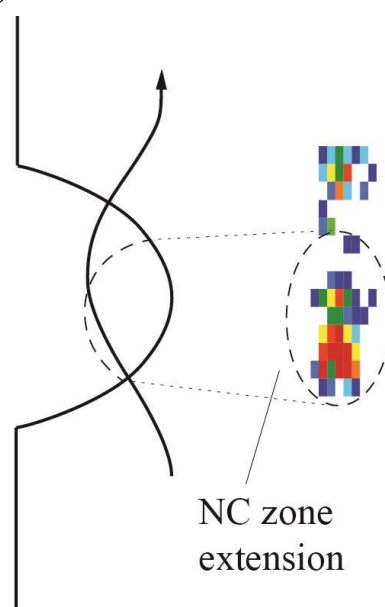
a) *Field ON*



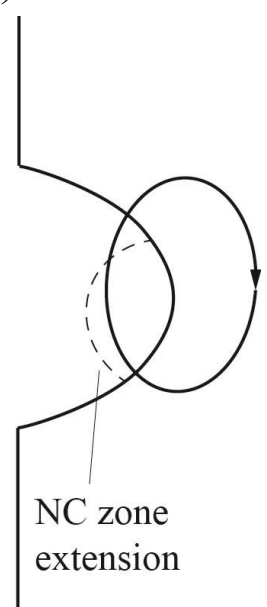
b) $< 1 \text{ mOe}$



c) *Field ON*



d) $< 1 \text{ mOe}$



Conclusions

First time demonstration: Q_0 degradation due to quench is related to **ambient field only**

- I. No Q_0 degradation when quenching in < 1 mOe
- II. Total recovery of Q_0 achieved when quenching in < 1 mOe

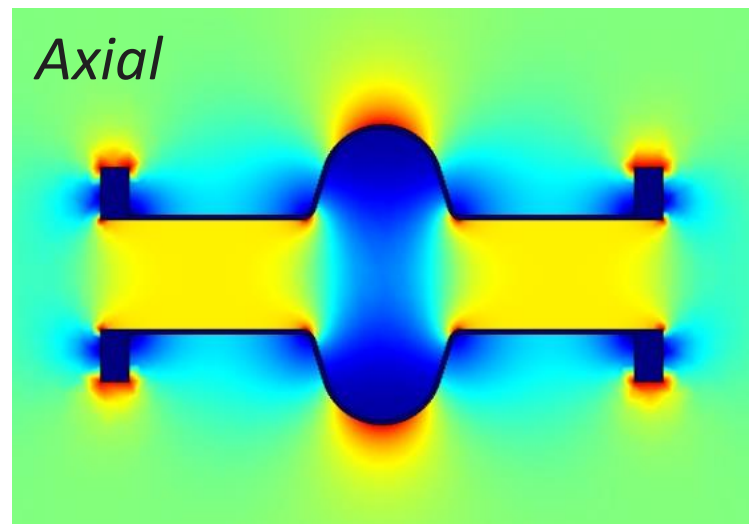
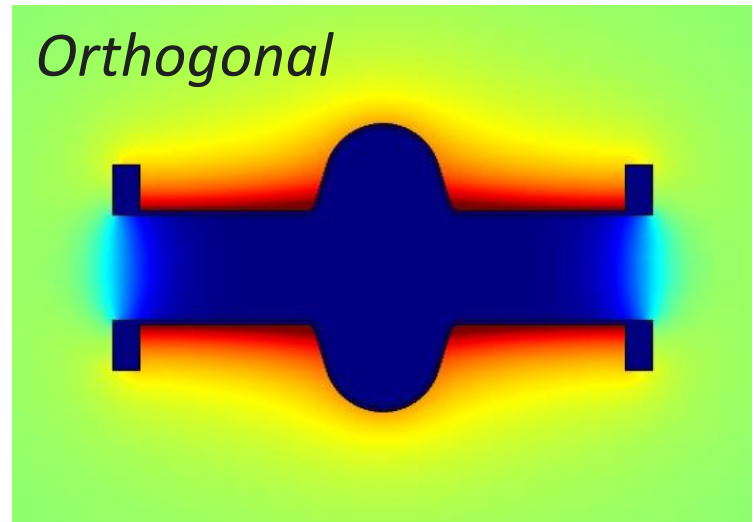
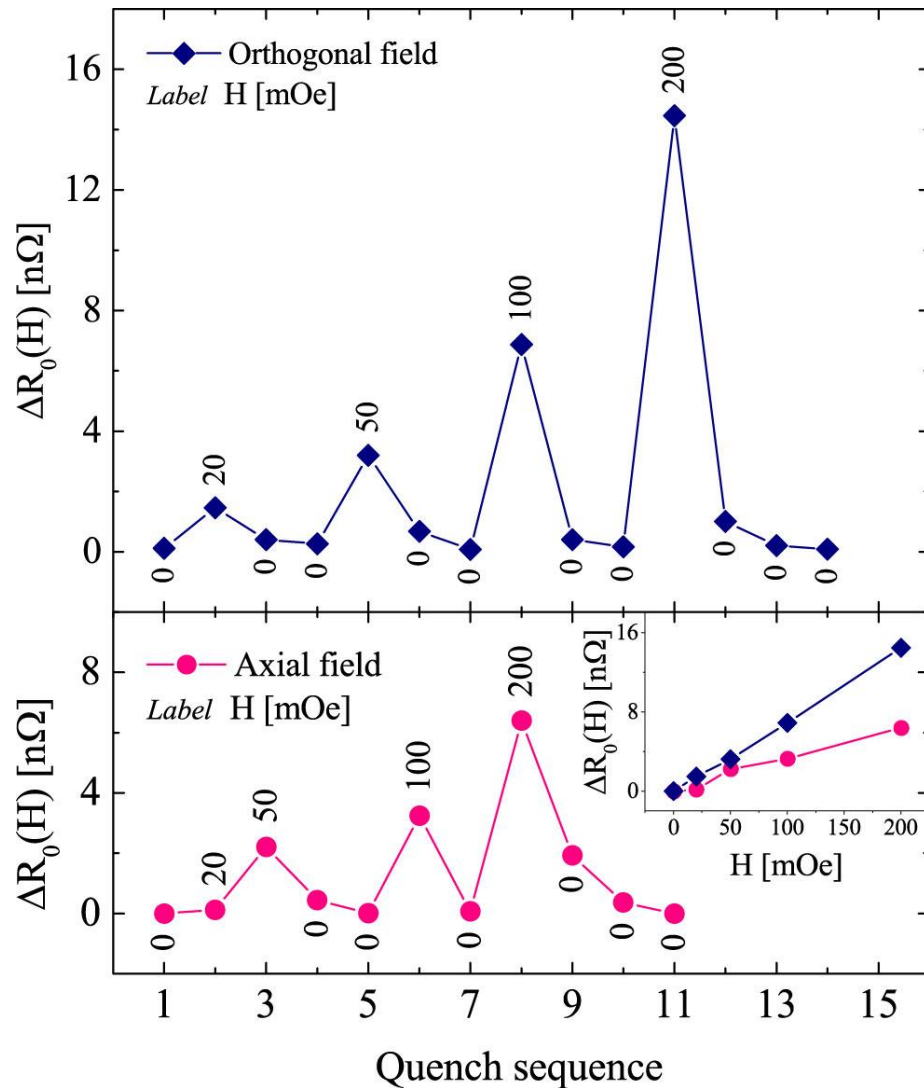
Above an external field threshold Q_0 cannot be recovered anymore

- I. Trapped field can migrate driven by its local thermal gradient

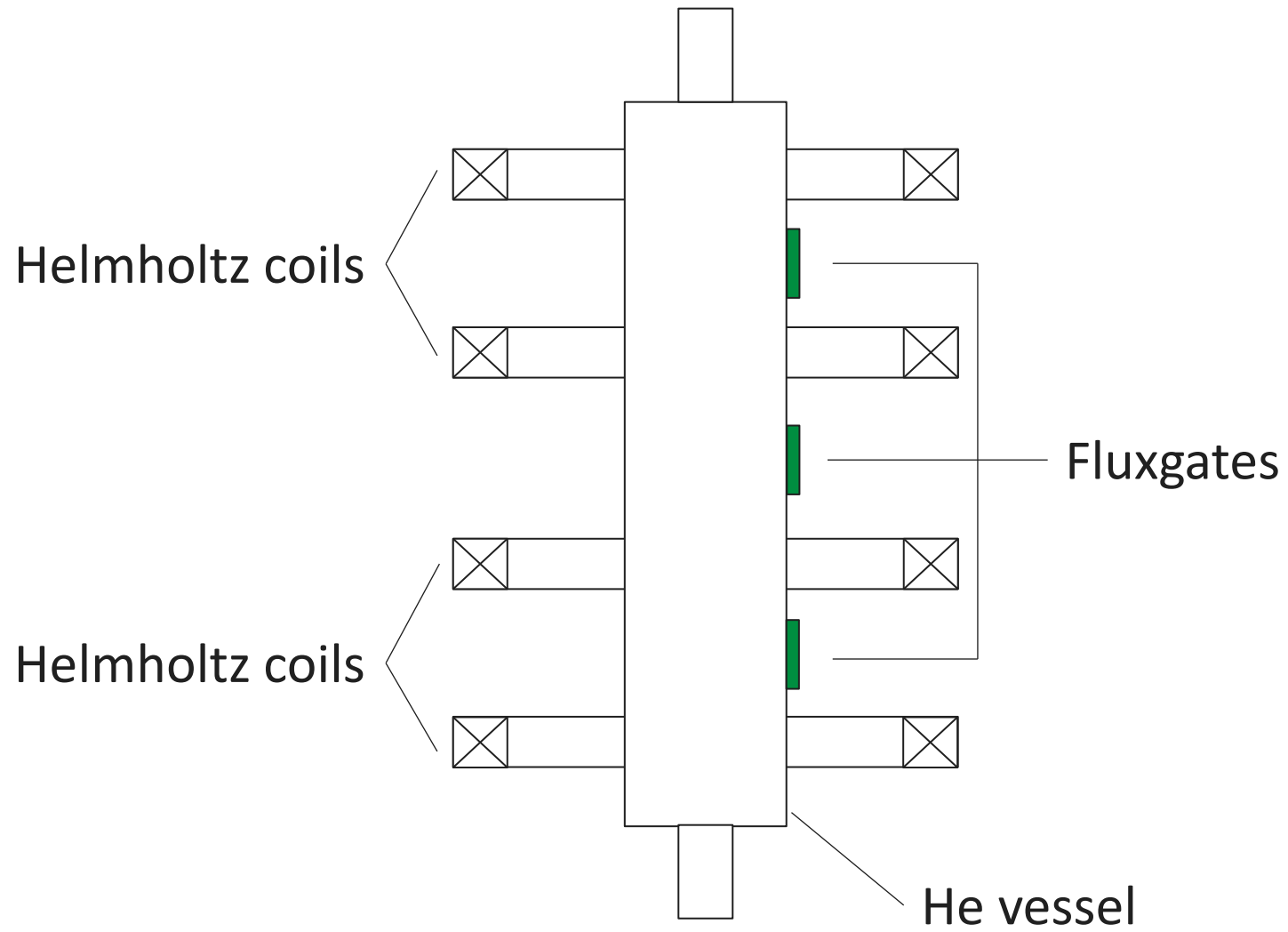
Thank you

Back-up Slides

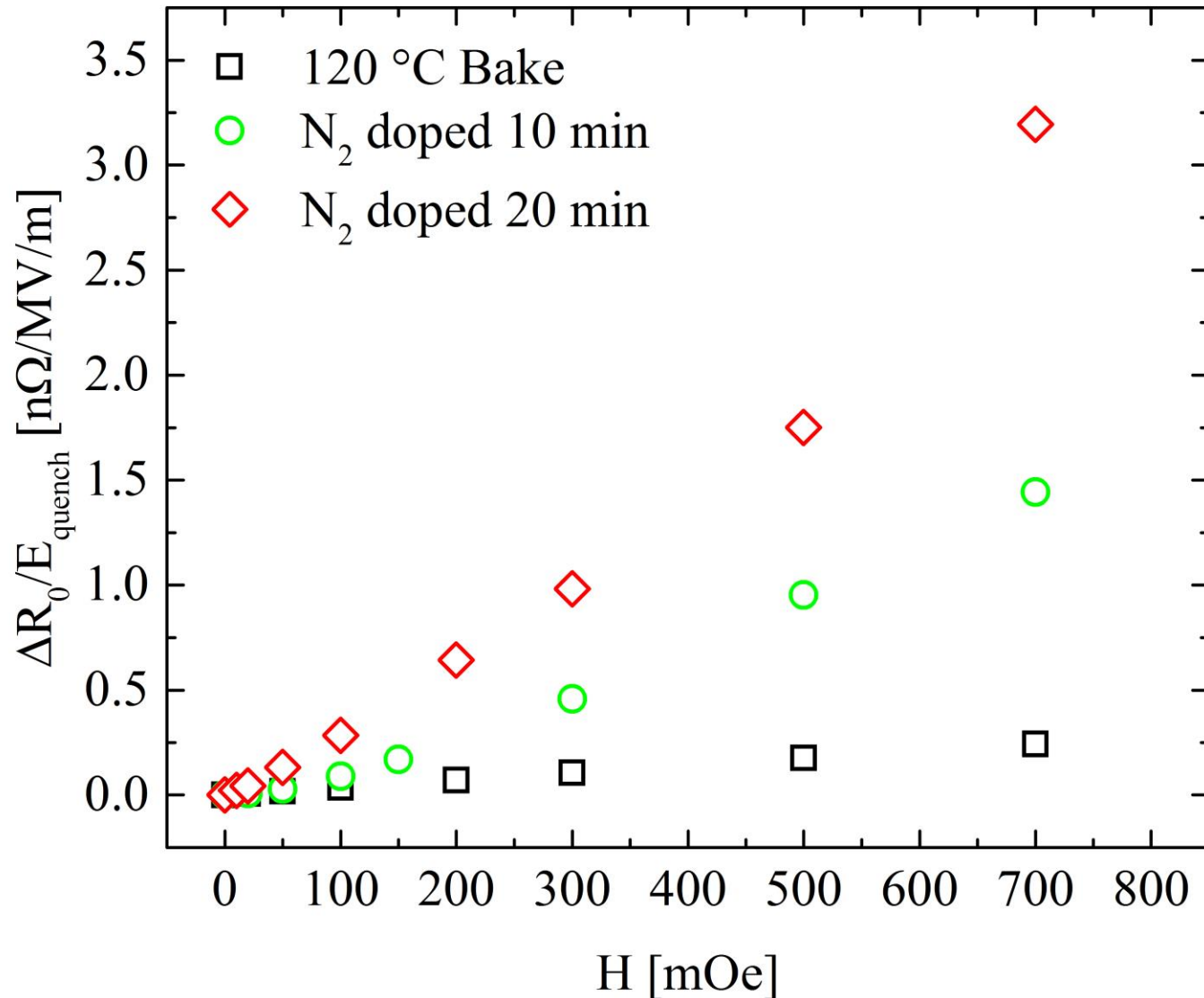
External field orientation dependence



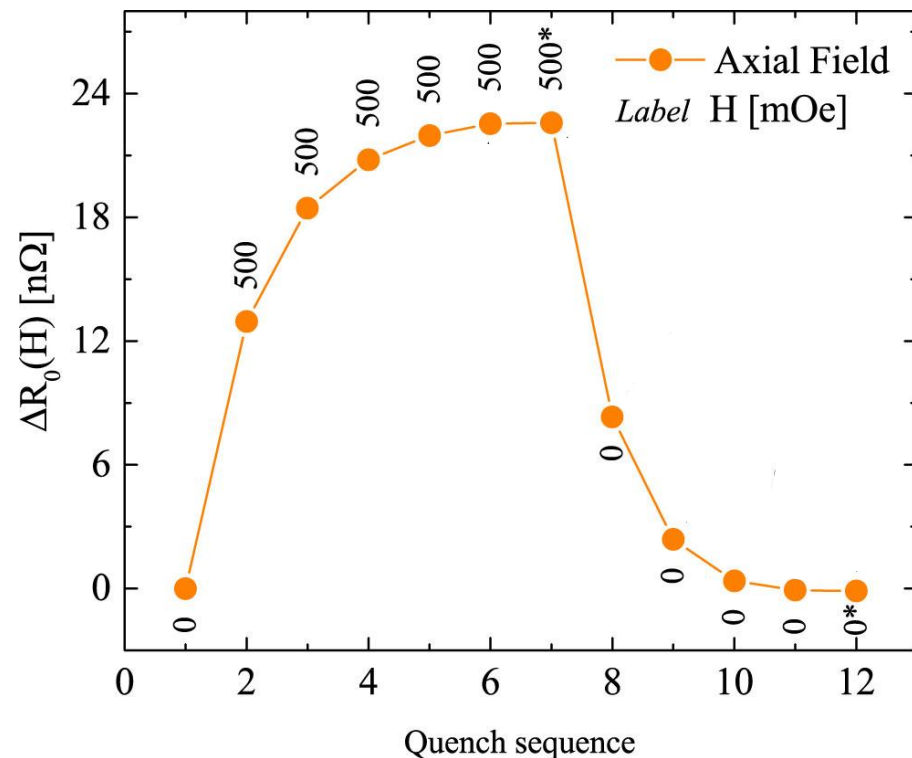
Dressed 9-cell set-up



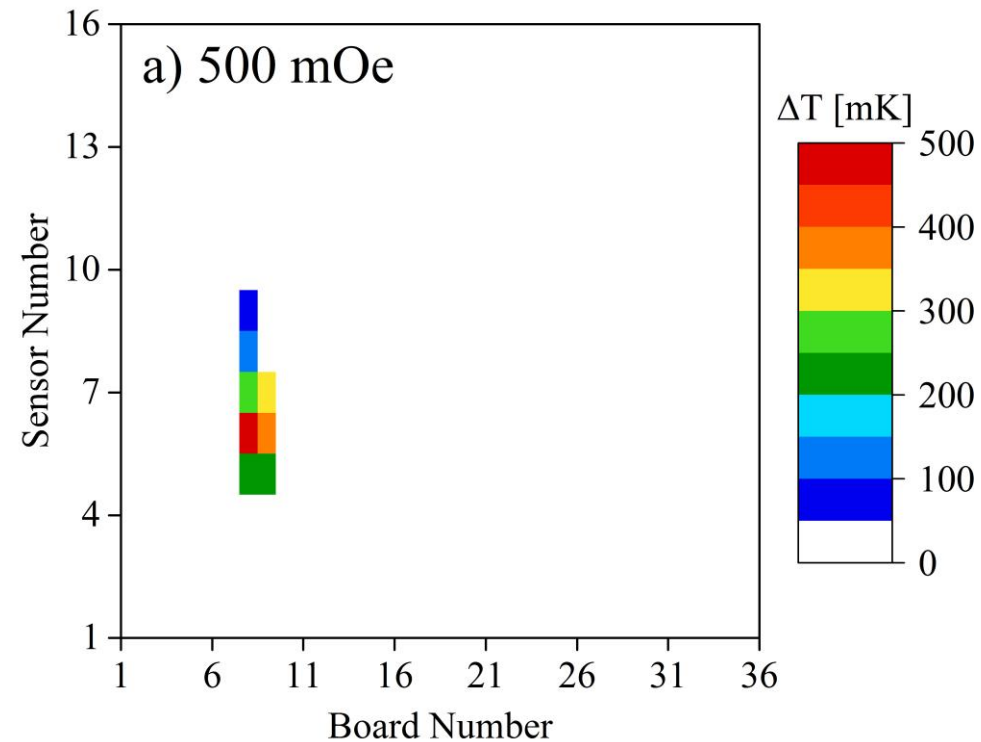
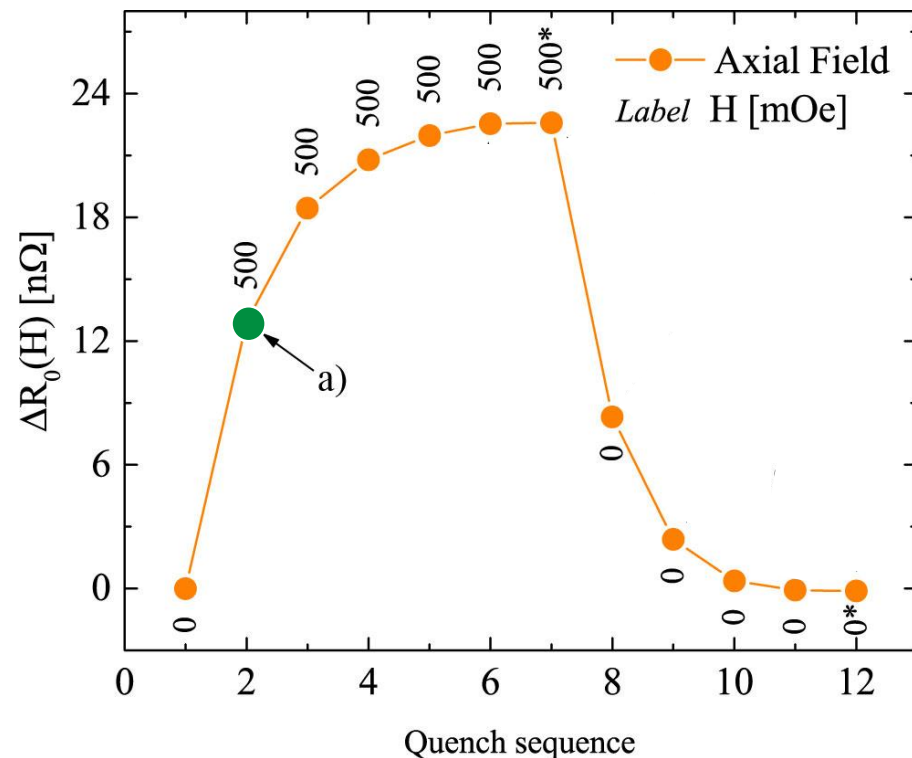
Dissipation comparison



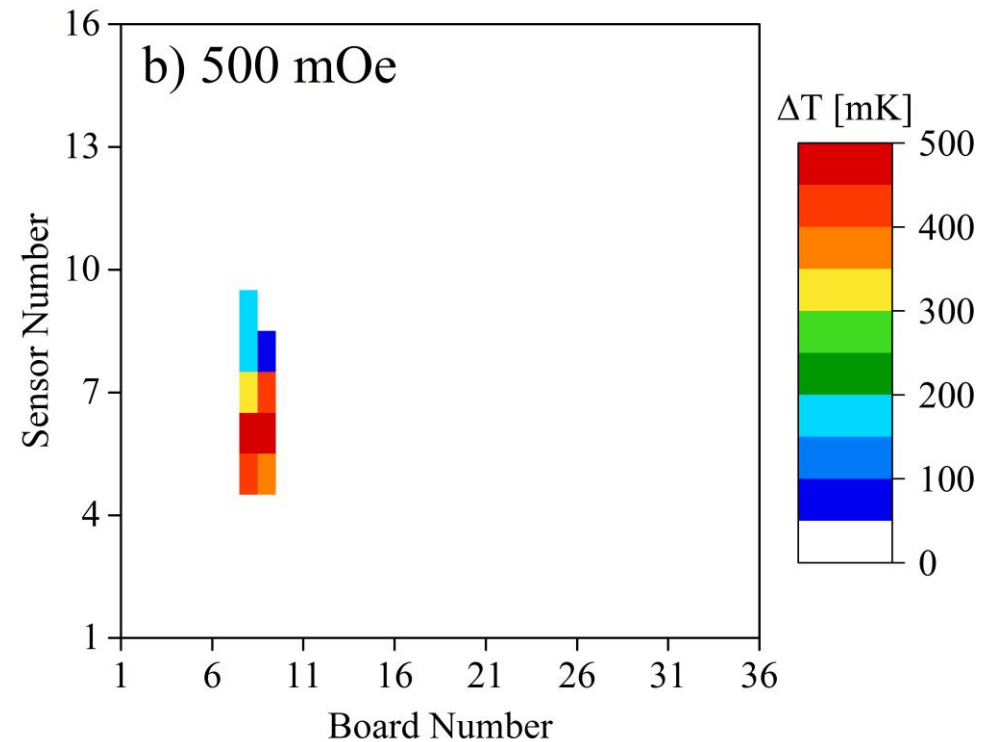
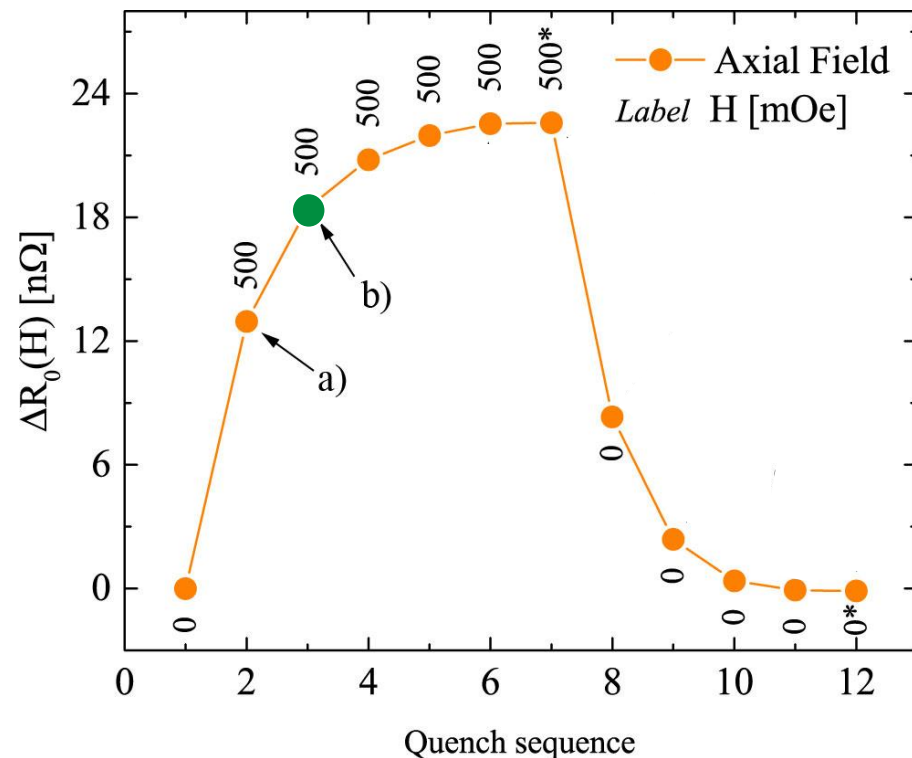
- I. Every quench depletes the local applied field at the quench spot
- II. The extra surface resistance saturates



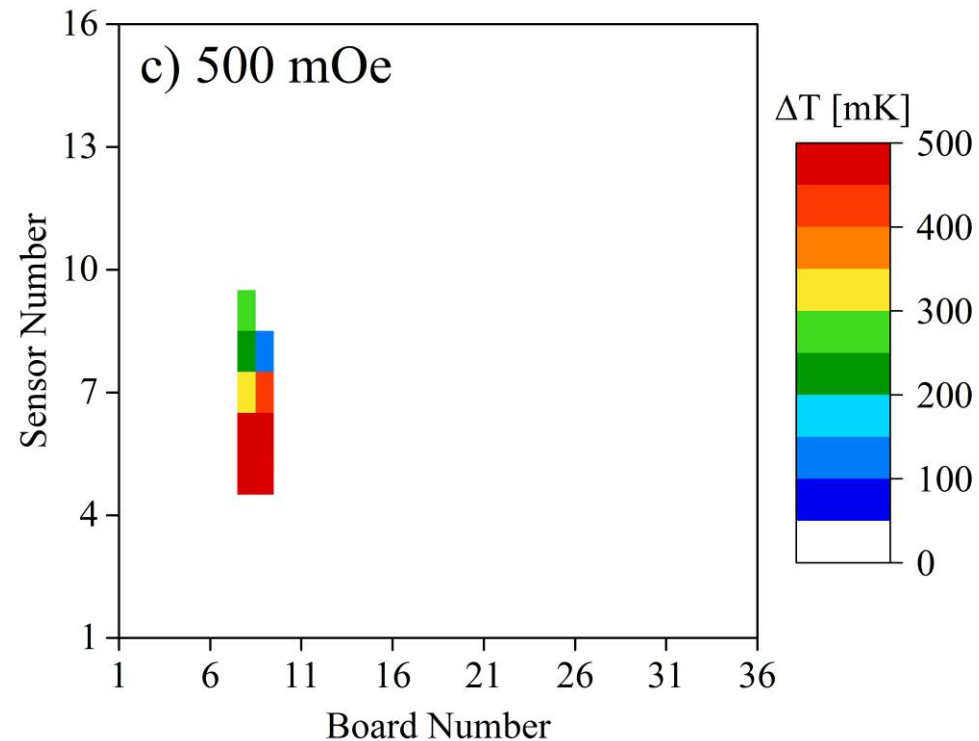
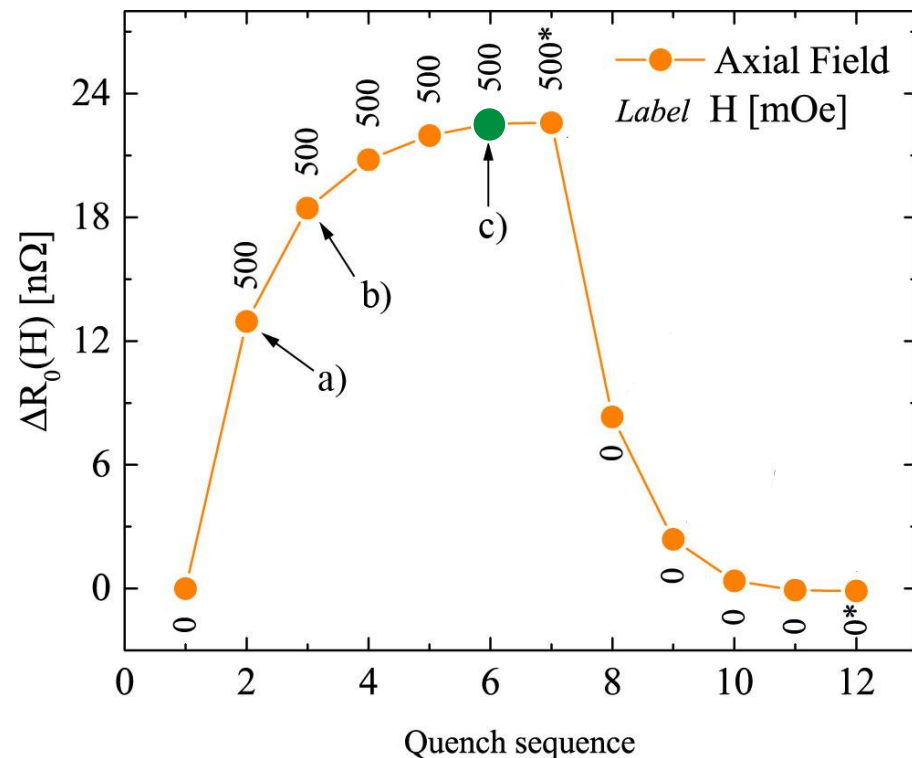
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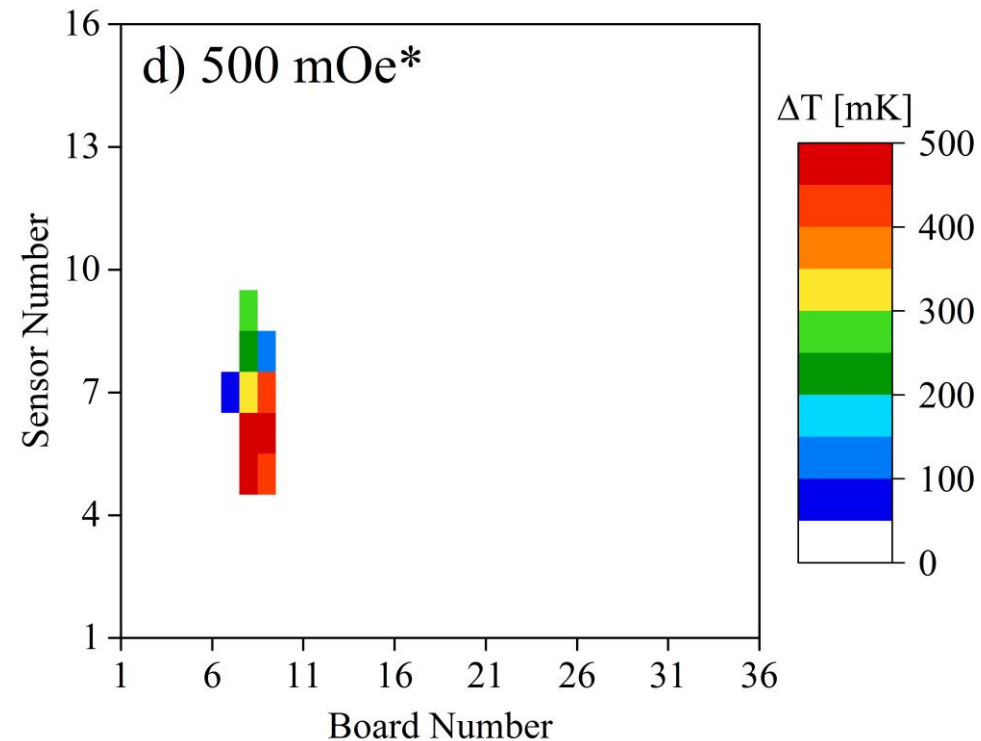
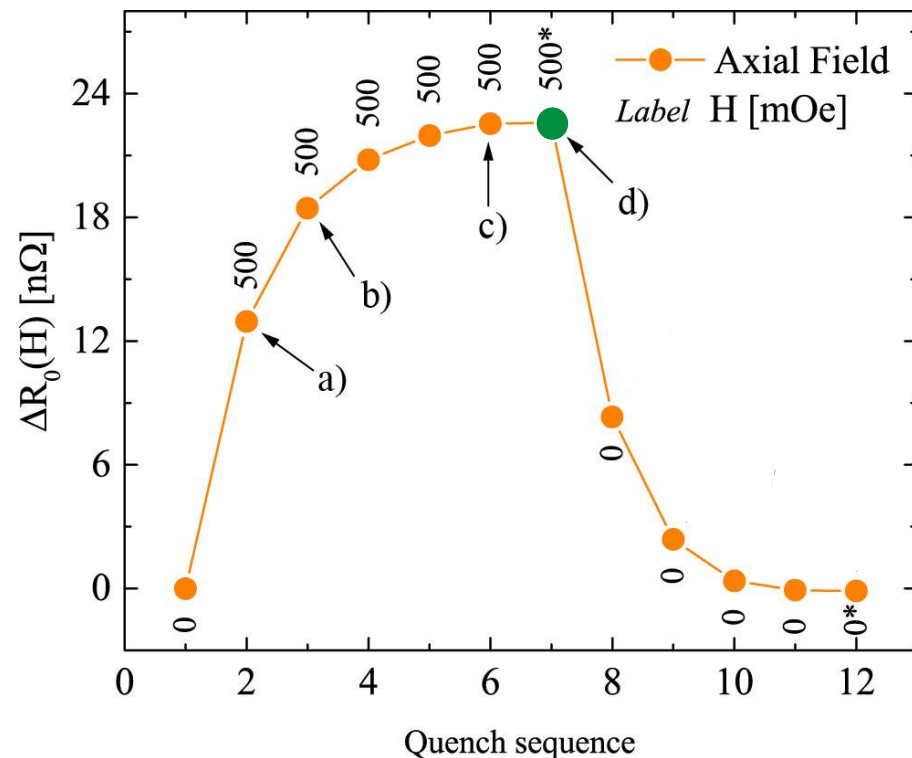
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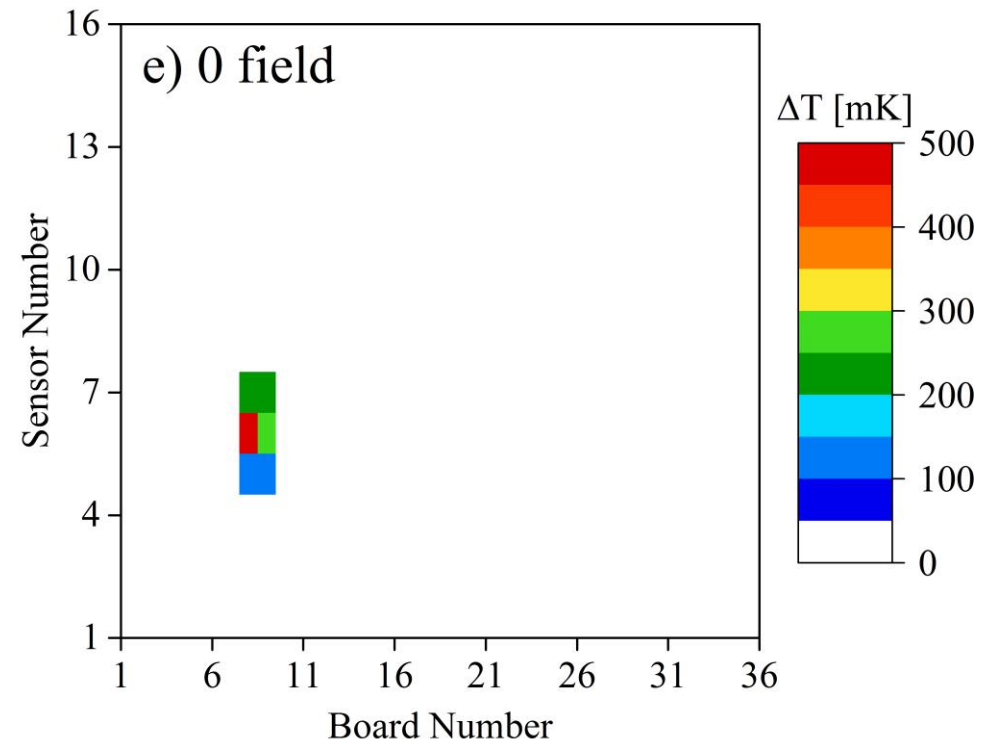
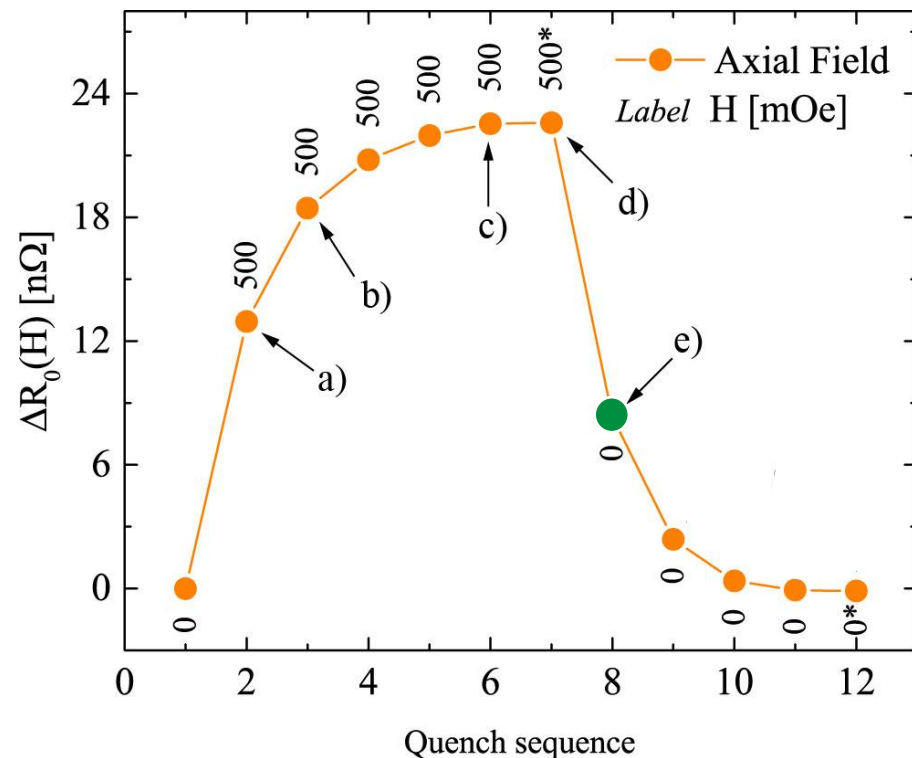
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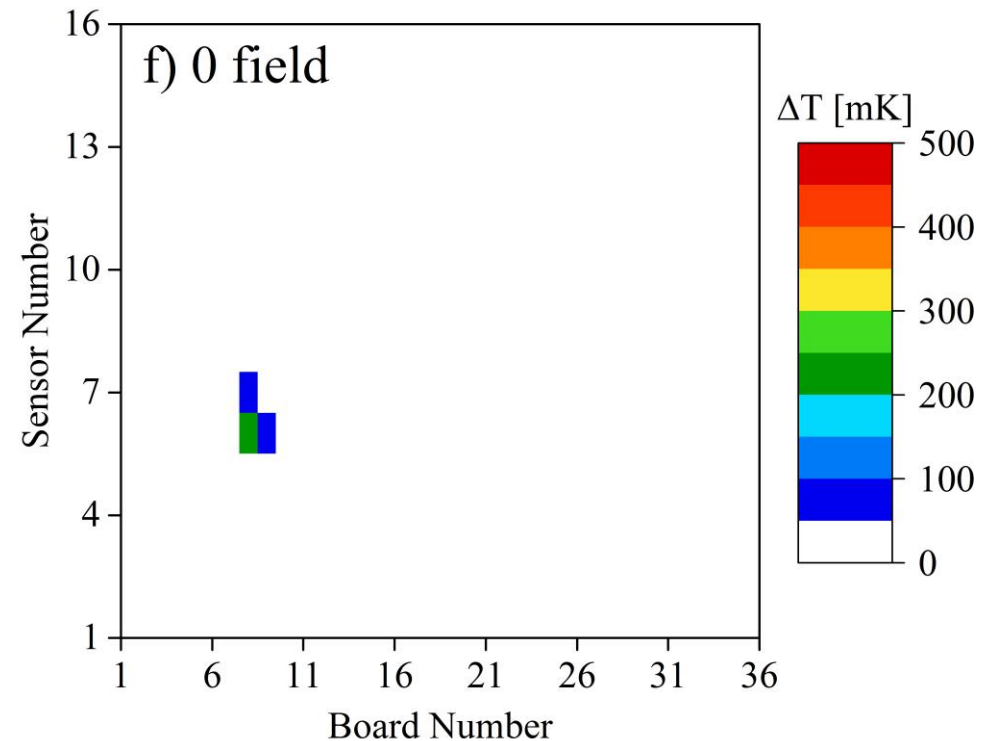
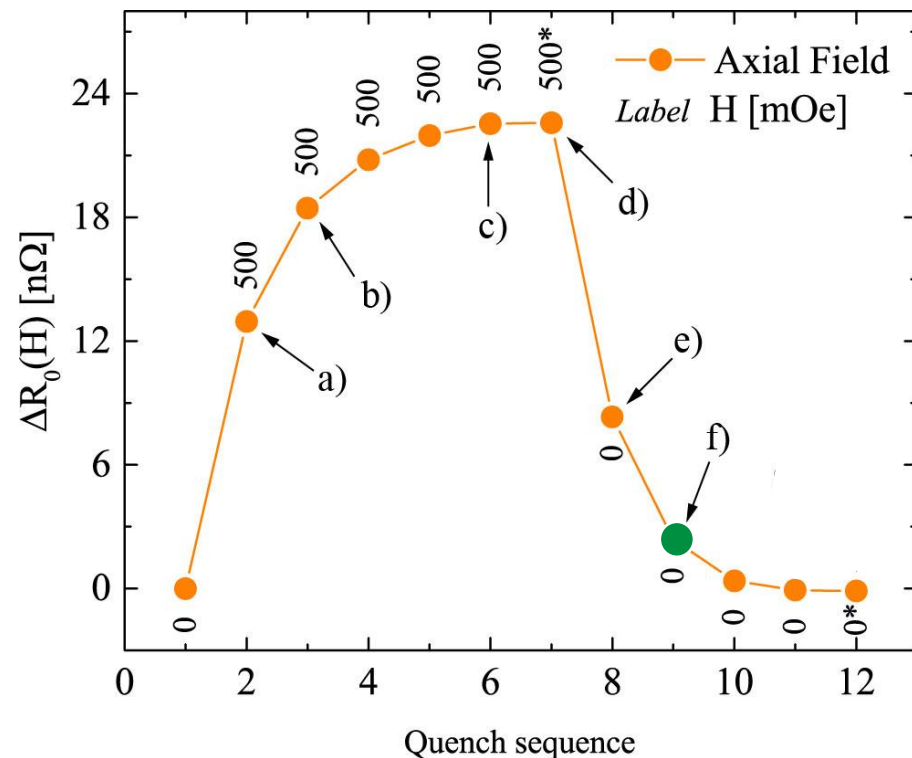
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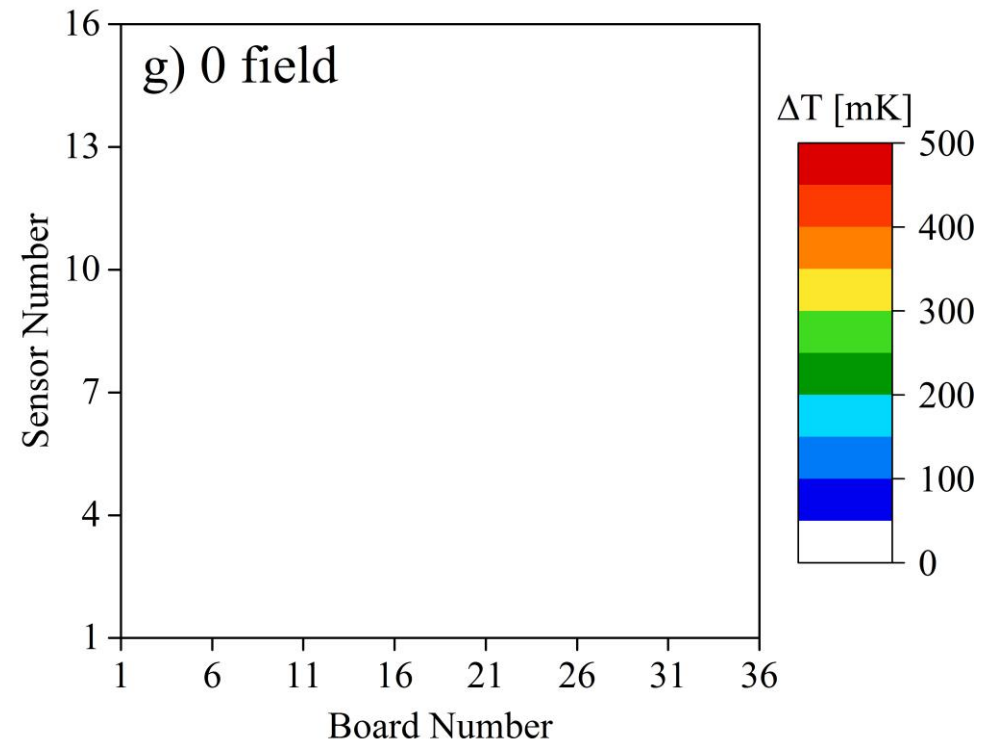
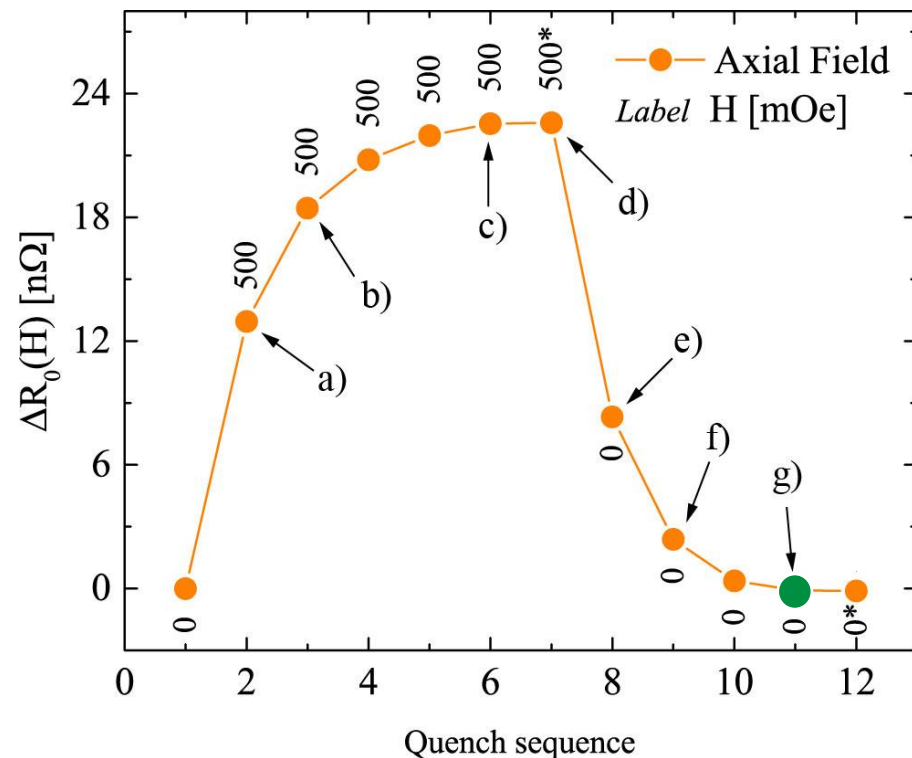
- I. Complete Q_0 recovery is not achieved with a single quench
- II. Several quenches in applied field < 1 mOe are needed



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